Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10613733	TAKAHASHI, KENJI
Examiner	Art Unit
Seth, Manav	2624

SEARCHED					
Class	Subclass	Date	Examiner		
382	162-167	2/20/2007	ms		
348	21.99,222.1,223.1,225.1,237,272-280	2/20/2007	ms		
358	500,515-523	2/21/2007	ms		

SEARCH NOTES				
Search Notes	Date	Examiner		
East (Text and class) search - see attached search notes	2/23/2007	ms		
IEEE Search	2/21/2007	ms		
STIC PLUS Search	2/21/2007	ms		
Inventor Search	2/23/2007	ms		
Interference Search	2/23/2007	ms		
Consulted Wenpeng Chen (Primary Examiner)	2/20/2007	ms		
Consulted Ishrat Sherali (Primary Examiner)	2/20/2007	ms		
Consulted Vikram Bali (Primary Examiner)	2/20/2007	ms		
Consulted Bhavesh Mehta (SPE)	2/22/2007	ms		

INTERFERENCE SEARCH					
Class	Subclass	Date	Examiner		
	PGPUB Text Search	2/23/2007	ms		